Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination MEYER ET AL.	
10/619,044		
Examiner	Art Unit	
C SAYALA	1761	

SEARCHED					
Class	Subclass	Date	Examiner		
426	1	6/7/2007	cs		
43	57.1				
69	30				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1, 20				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
search updated	6/7/2007	cs		